June 2008

FDJ1032C Complementary PowerTrench[®] MOSFET

Features

■ Q1 -2.8 A, -20 V.

FAIRCHILD SEMICONDUCTOR

- $\begin{array}{l} R_{DS(ON)} = 160 \ m\Omega \ @ \ V_{GS} = -4.5 \ V \\ R_{DS(ON)} = 230 \ m\Omega \ @ \ V_{GS} = -2.5 \ V \\ R_{DS(ON)} = 390 \ m\Omega \ @ \ V_{GS} = -1.8 \ V \end{array}$
- $\label{eq:rescaled} \begin{array}{|c|c|c|} \blacksquare \mbox{ Q2 } & 3.2 \mbox{ A}, \mbox{ 20 V}. & R_{DS(ON)} = 90 \mbox{ } m\Omega \end{tabular} \mbox{ V}_{GS} = 4.5 \mbox{ V} \\ R_{DS(ON)} = 130 \mbox{ } m\Omega \end{tabular} \end{tabular} \mbox{ V}_{GS} = 2.5 \mbox{ V} \end{array}$
- Low gate charge
- High performance trench technology for extremely low R_{DS(ON)}

S2

S1

- FLMP SC75 package: Enhanced thermal performance in industry-standard package size
- RoHS Compliant

Applications

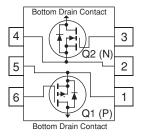
- DC/DC converter
- Load switch
- Motor Driving

General Description

These N & P-Channel MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize on-state resistance and yet maintain superior switching performance.

These devices are well suited for low voltage and battery powered applications where low in-line power loss and fast switching are required.

G1 S1 S2 G2 S1



Absolute Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter		Q1	Q2	Units
V _{DSS}	Drain-Source Voltage		-20	20	V
V _{GSS}	Gate-Source Voltage		±8	±12	V
ID	Drain Current – Continuous	(Note 1a)	-2.8	3.2	A
	– Pulsed		-12	12	
P _D	Power Dissipation for Single Operation (Note 1a) 1.5		5	W	
		(Note 1b)	0.	9	
T _J , T _{STG}	Operating and Storage Junction Temperature Range		–55 to	°C	
Thermal Cha	racteristics				
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	80		°C/W
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	(Note 1a)	5		

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Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
.H	FDJ1032C	7"	8mm	3000 units

Electrical Characteristics

Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Off Charact	eristics						,
BV _{DSS}	Drain-Source Breakdown Voltage	$ \begin{array}{l} V_{GS} = 0 \; V, \; I_{D} = -250 \; \mu A \\ V_{GS} = 0 \; V, \; I_{D} = 250 \; \mu A \end{array} $	Q1 Q2	-20 20			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = -250 \ \mu$ A, Referenced to 25°C $I_D = 250 \ \mu$ A, Referenced to 25°C	Q1 Q2		-13 13		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -16 V, V_{GS} = 0 V$ $V_{DS} = 16 V, V_{GS} = 0 V$	Q1 Q2			-1 1	μA
I _{GSS}	Gate-Body Leakage	$V_{GS} = \pm 8 V, V_{DS} = 0 V$ $V_{GS} = \pm 12 V, V_{DS} = 0 V$	Q1 Q2			±100 ±100	nA
On Charact	eristics (Note 2)						
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = -250 \ \mu A$ $V_{DS} = V_{GS}, I_D = 250 \ \mu A$	Q1 Q2	-0.4 0.6	-0.8 1.0	-1.5 1.5	V
$\frac{\Delta V_{\text{GS(th)}}}{\Delta T_{\text{J}}}$	Gate Threshold Voltage Temperature Coefficient	$I_D = -250 \ \mu$ A, Referenced to 25°C $I_D = 250 \ \mu$ A, Referenced to 25°C	Q1 Q2		3 _3		mV/°C
R _{DS(on)}	Static Drain-Source On-Resistance	$ \begin{split} & V_{GS} = -4.5 \text{ V}, \text{ I}_{D} = -2.8 \text{ A} \\ & V_{GS} = -2.5 \text{ V}, \text{ I}_{D} = -2.2 \text{ A} \\ & V_{GS} = -1.8 \text{ V}, \text{ I}_{D} = -1.7 \text{ A} \\ & V_{GS} = -4.5 \text{ V}, \text{ I}_{D} = 2.8 \text{ A}, \text{ T}_{J} = 125^{\circ}\text{C} \end{split} $	Q1		108 163 283 150	160 230 390 238	mΩ
		$ \begin{array}{l} V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 3.2 \text{ A} \\ V_{GS} = 2.5 \text{ V}, \text{ I}_{D} = 2.7 \text{ A} \\ V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 3.2, \text{ T}_{J} = 125^{\circ}\text{C} \end{array} $	Q2		70 100 83	90 130 132	
9 _{FS}	Forward Transconductance	$V_{DS} = -5 V$, $I_D = -2.8 A$ $V_{DS} = 5 V$, $I_D = 3.2 A$	Q1 Q2		5 7.5		S
Dynamic Cl	haracteristics						
C _{iss}	Input Capacitance	Q1: V _{DS} = -10 V, V _{GS} = 0 V, f = 1.0 MHz	Q1 Q2		290 200		pF
C _{oss}	Output Capacitance	Q2: V _{DS} = 10 V, V _{GS} = 0 V, f = 1.0 MHz	Q1 Q2		55 50		pF
C _{rss}	Reverse Transfer Capacitance	VDS = 10 V, VGS = 0 V, 1 = 1.0 WH2	Q1 Q2		29 30		pF
R _G	Gate Resistance		Q1 Q2		14 3		Ω
Switching C	Characteristics						
t _{d(on)}	Turn-On Delay Time	Q1: $V_{DD} = -10 \text{ V}, \text{ I}_{D} = -1 \text{ A},$	Q1 Q2		8 7	16 14	ns
t _r	Turn-On Rise Time	$V_{GS} = -4.5 \text{ V}, \text{ R}_{GEN} = 6 \Omega$	Q1 Q2		13 8	23 16	ns
t _{d(off)}	Turn-Off Delay Time	$V_{DD} = 10$ V, $I_D = 1$ A, V _{GS} = 4.5V, R _{GEN} = 6 Ω	Q1 Q2		13 11	23 20	ns
t _f	Turn-Off Fall Time		Q1 Q2		18 2	32 4	ns

Electrical Characteristics (Continued)

Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Qg	Total Gate Charge	Q1: $V_{DS} = -10 \text{ V}, \text{ I}_{D} = -2.8 \text{ A}, \text{ V}_{GS} = -4.5 \text{ V}$	Q1 Q2		3 2	4 3	nC
Q _{gs}	Gate-Source Charge	Q2: V _{DS} = 10 V, I _D = 3.2 A, V _{GS} = 4.5 V	Q1 Q2		0.65 0.4		nC
Q _{gd}	Gate-Drain Charge	- VDS - 10 V, 1D - 3.2 A, VGS - 4.3 V	Q1 Q2		0.75 1.0		nC
Drain-Source	e Diode Characteristics and Ma	ximum Ratings					
I _S	Maximum Continuous Drain-Source Diode Forward Current		Q1 Q2			-1.25 1.25	A
V _{SD}	Drain-Source Diode Forward Voltage		Q1 Q2		-0.8 0.8	-1.2 1.2	V
t _{rr}	Diode Reverse Recovery Time	$ \begin{array}{l} I_F = -4.2 \text{A}, \ d_{IF}/d_t = 100 \ \text{A}/\mu \text{s} \\ I_F = \ 5.9 \text{A}, \ d_{IF}/d_t = 100 \ \text{A}/\mu \text{s} \end{array} $	Q1 Q2		14 11		nS
Q _{rr}	Diode Reverse Recovery Charge	$ \begin{array}{l} I_F = -4.2A, \ d_{IF}/d_t = 100 \ A/\mu s \\ I_F = \ 5.9A, \ d_{IF}/d_t = 100 \ A/\mu s \end{array} $	Q1 Q2		4 2.5		nC

Notes:

1. R_{6JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{6JC} is guaranteed by design while R_{6CA} is determined by the user's board design.



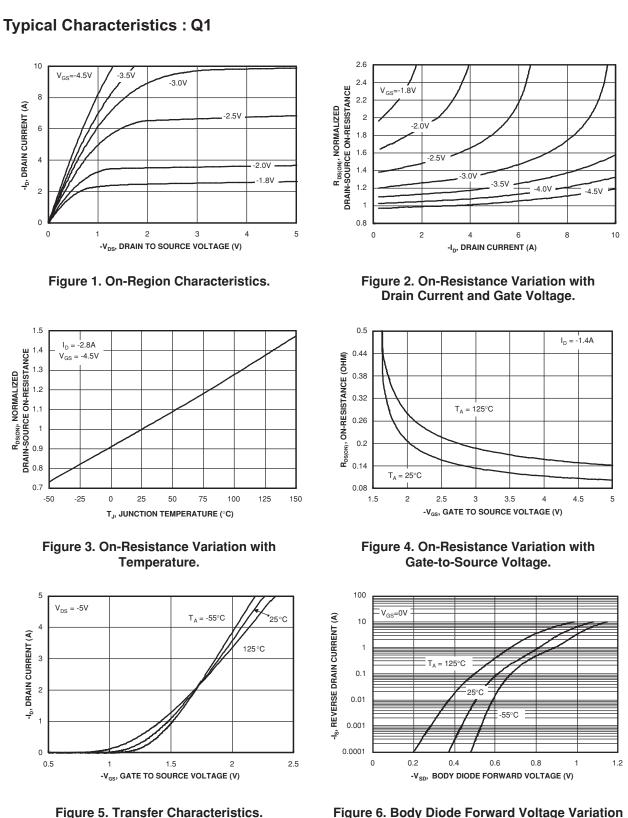
 a) 80°C/W when mounted on a 1in² pad of 2 oz copper (Single Operation).



b) 140°C/W when mounted on a minimum pad of 2 oz copper (Single Operation).

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%



with Source Current and Temperature.

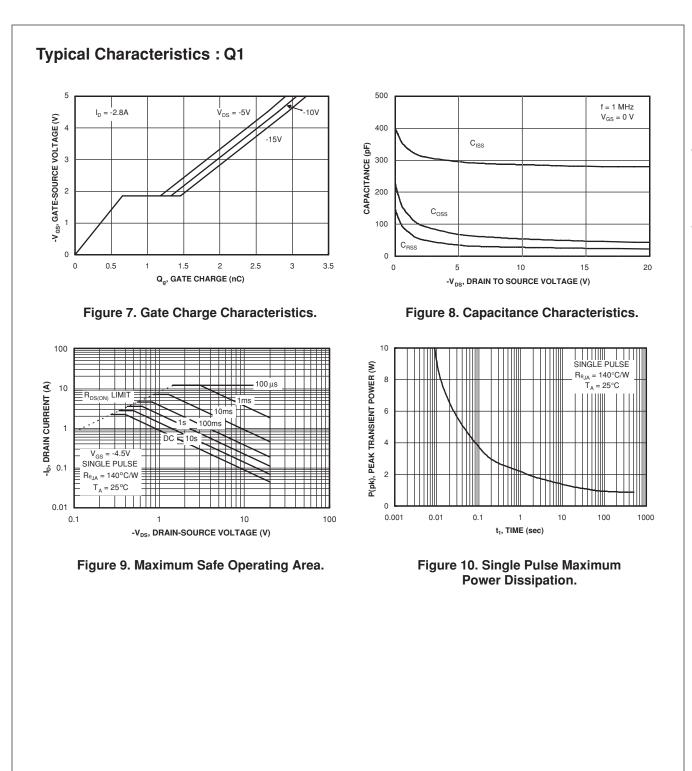
-I_b, DRAIN CURRENT (A)

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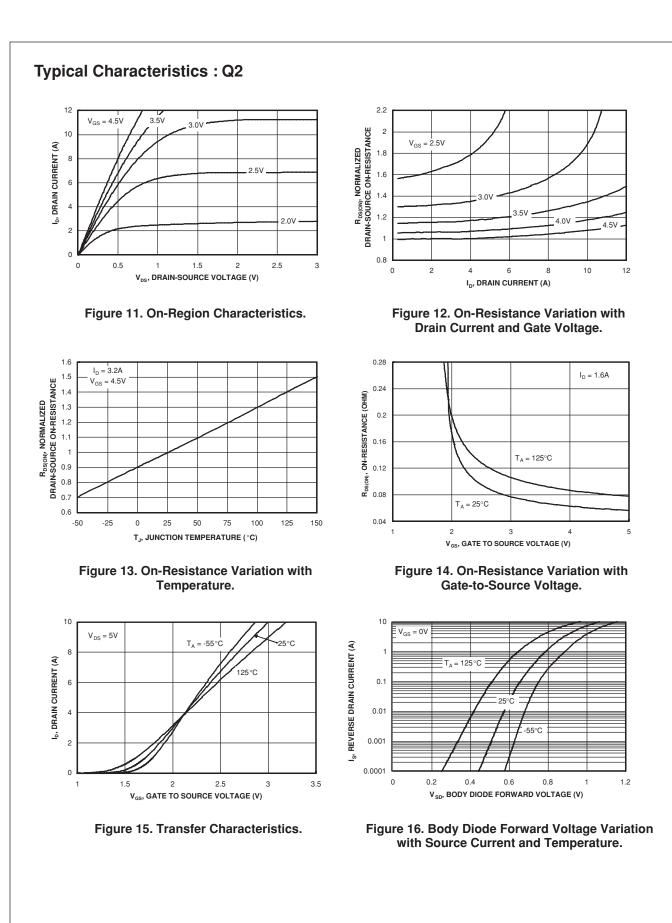
-I_D, DRAIN CURRENT (A)

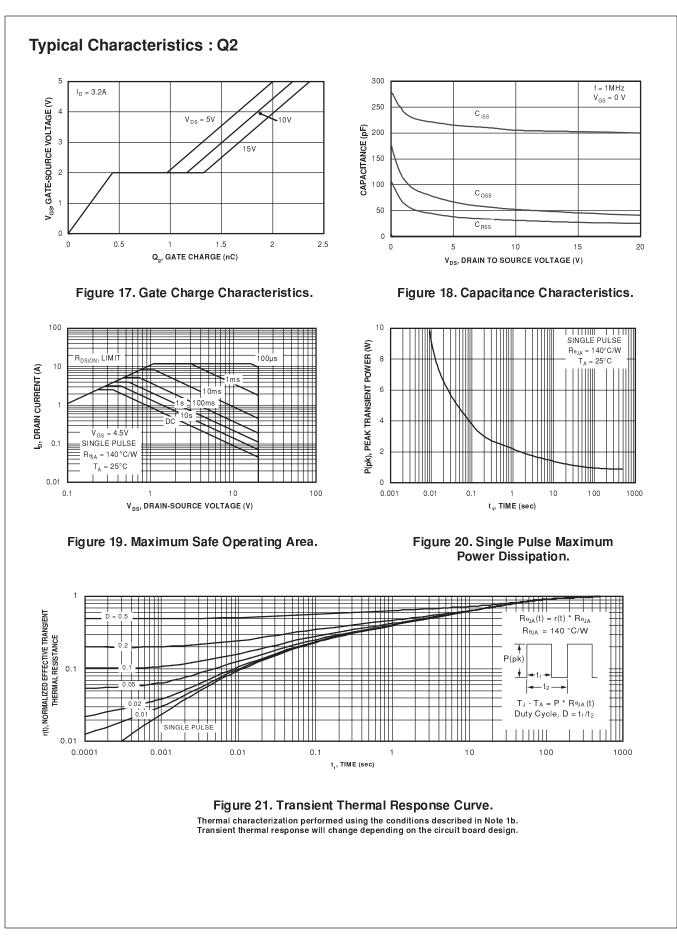
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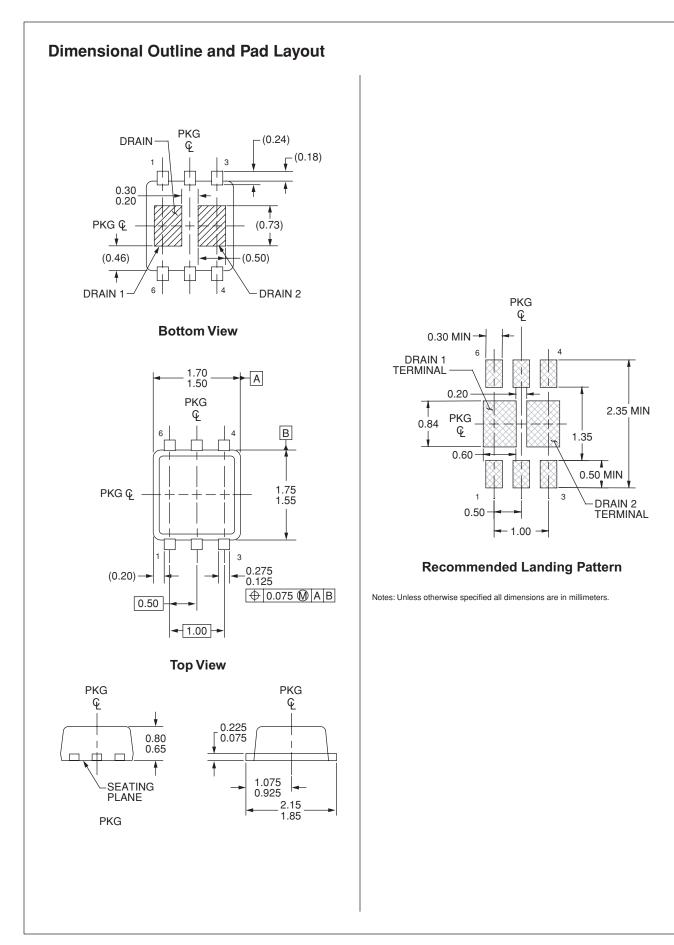
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